			Application/Control No		Applicant(s)/Pat	Applicant(s)/Patent under Reexamination	Hon
Issi	Issue Classification	uo uo	10054735		NAKAMURA ET AL	AL.	
			Examiner		Art Unit		
			Nguyen, Huy D		2617		
	ORI	ORIGINAL		INTE	RNATIONAL	INTERNATIONAL CLASSIFICATION	Z
	CLASS		SUBCLASS	CLAIMED	Ω	NON-CLAIMED	AIMED
455		432.3		Q 4 O	7 / 20		
	CROSS REFERENCE(S)	FERENCE	(S)	·			
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455	432.1 43	433 435.1	5.1	_			
护) (Assistant Examiner)		6/1/06 (Date)	The state of the s	D.		Total Claims Allowed:	s Allowed:
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